ON Semiconductor

Is Now



To learn more about onsemi™, please visit our website at www.onsemi.com

onsemi and ONSEMI. and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. onsemi reserves the right to make changes at any time to any products or information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/ or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use onsemi products for any such unintended or unauthorized application,

MOSFET - N-Channel, Shielded Gate, POWERTRENCH®

150 V, 9.4 A, 134 mΩ

FDMC86244, FDMC86244-L701

General Description

This N-Channel MOSFET is produced using ON Semiconductor's advanced POWERTRENCH process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance.

Features

- Max $r_{DS(on)} = 134 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 2.8 \text{ A}$
- Max $r_{DS(on)} = 186 \text{ m}\Omega$ at $V_{GS} = 6 \text{ V}$, $I_D = 2.4 \text{ A}$
- Low Profile 1 mm Max in Power 33
- 100% UIL Tested
- These Devices are Pb-Free and are RoHS Compliant

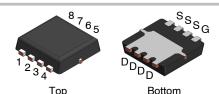
Applications

• DC – DC Conversion



ON Semiconductor®

www.onsemi.com



WDFN8 3.3x3.3, 0.65P CASE 511DR

FDMC86244



WDFN8 3.3x3.3, 0.65P

CASE 511DQ

FDMC86244-L701

MARKING DIAGRAM



FDMC 86244 ALYW

Bottom

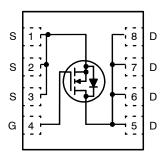
FDMC86244 FDMC86244-L701

FDMC86244 = Specific Device Code A = Assembly Site XY = 2-Digit Date Code

KK = 2-Digit Lot Run Traceability Code

L = Wafer Lot Number YW = Assembly Start Week

PIN ASSIGNMENT



ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

MOSFET MAXIMUM RATINGS ($T_A = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter			Ratings	Unit
V _{DS}	Drain to Source Voltage		150	V	
V _{GS}	Gate to Source Voltage				
I _D	Drain Current	Continuous	T _C = 25°C	9.4	Α
		Continuous (Note 2a)	T _A = 25°C	2.8	
		Pulsed	•	12	
E _{AS}	Single Pulse Avalanche Energy	lanche Energy (Note 1)		12	mJ
P_{D}	Power Dissipation $T_C = 25^{\circ}C$			26	W
	Power Dissipation (Note 2a) $T_A = 25^{\circ}C$			2.3	
T _J , T _{STG}	Operating and Storage Junction	Temperature Range	•	-55 to +150	°C

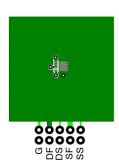
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Starting $T_J = 25^{\circ}C$; N-ch: L = 1.0 mH, $I_{AS} = 5.0$ A, $V_{DD} = 135$ V, $V_{GS} = 10$ V.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
Rejc	Thermal Resistance, Junction to Case	4.7	°C/W
RθJA	Thermal Resistance, Junction to Ambient (Note 2a)		

2. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined bythe user's board design.



a. 53°C/W when mounted on a 1 in² pad of 2 oz copper



b. 125°C/W when mounted on a minimum pad of 2 oz copper

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit	
OFF CHARA	ACTERISTICS			•			
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	150	_	-	V	
$\Delta BV_{DSS}/ \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C	-	106	_	mV/°C	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 120 V, V _{GS} = 0 V	-	_	1	μΑ	
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±20 V, V _{DS} = 0 V	-	_	±100	nA	
ON CHARAC	CTERISTICS						
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2	2.6	4	V	
$\Delta V_{GS(th)}$ / ΔT_J	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C	-	-9	=	mV/°C	
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 2.8 A	-	105	134	mΩ	
		V _{GS} = 6 V, I _D = 2.4 A	-	120	186	1	
		V _{GS} = 10 V, I _D = 2.8 A, T _J = 125°C	-	199	254	1	
9FS	Forward Transconductance	V _{DS} = 10 V, I _D = 2.8 A	-	8	-	S	
DYNAMIC C	HARACTERISTICS				•		
C _{iss}	Input Capacitance	V _{DS} = 75 V, V _{GS} = 0 V, f = 1 MHz	-	257	345	pF	
C _{oss}	Output Capacitance	-		32	45	pF	
C _{rss}	Reverse Transfer Capacitance			1.8	5	pF	
SWITCHING	CHARACTERISTICS						
t _{d(on)}	Turn-On Delay Time	V_{DD} = 75 V, I_{D} = 2.8 A, V_{GS} = 10 V, R_{GEN} = 6 Ω		5.3	11	ns	
t _r	Rise Time			1.5	10	ns	
t _{d(off)}	Turn-Off Delay Time	1	-	9.9	20	ns	
t _f	Fall Time	1	-	2.3	10	ns	
Q _{g(TOT)}	Total Gate Charge	$V_{GS} = 0 \text{ V to } 10 \text{ V}, V_{DD} = 75 \text{ V}, I_D = 2.8 \text{ A}$	-	4.2	5.9	nC	
Q _{g(TOT)}	Total Gate Charge	$V_{GS} = 0 \text{ V to 5 V}, V_{DD} = 75 \text{ V}, I_D = 2.8 \text{ A}$	-	2.4	3.4	nC	
Q _{gs}	Total Gate Charge	V _{DD} = 75 V, I _D = 2.8 A	-	1.1	-	nC	
Q _{gd}	Gate to Drain "Miller" Charge	1	-	1.0	-	nC	
DRAIN-SOL	IRCE DIODE CHARACTERISTICS				-	-	
V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 2.8 A (Note 3)	-	0.81	1.3	V	
		V _{GS} = 0 V, I _S = 2 A (Note 3)	-	0.79	1.2	7	
t _{rr}	Reverse Recovery Time	I _F = 2.8 A, di/dt = 100 A/μs	-	48	76	ns	
Q _{rr}	Reverse Recovery Charge		-	38	61	nC	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: Pulse Width < 300 µs, Duty cycle < 2.0%.

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

5

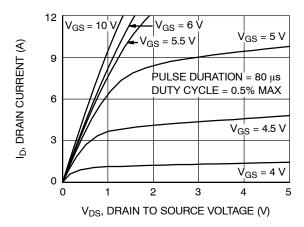


Figure 1. On Region Characteristics

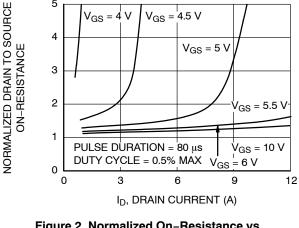


Figure 2. Normalized On-Resistance vs. **Drain Current and Gate Voltage**

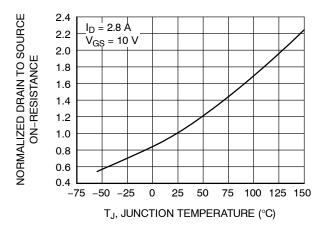


Figure 3. Normalized On Resistance vs. **Junction Temperature**

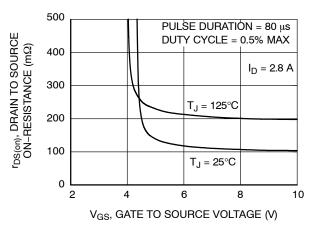


Figure 4. On-Resistance vs. Gate to Source Voltage

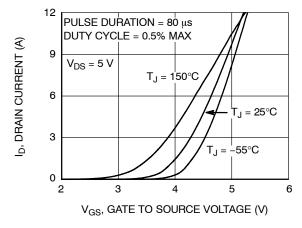


Figure 5. Transfer Characteristics

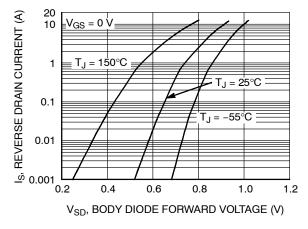


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

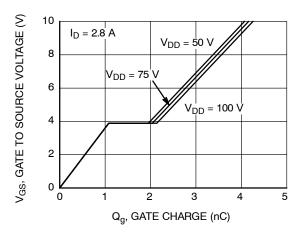


Figure 7. Gate Charge Characteristics

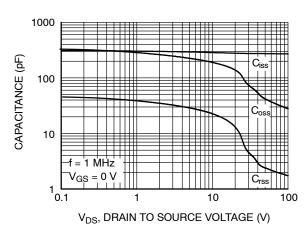


Figure 8. Capacitance vs. Drain to Source Voltage

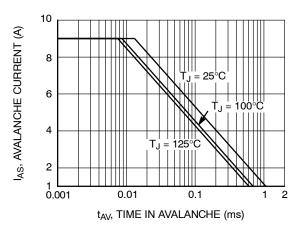


Figure 9. Unclamped Inductive Switching Capability

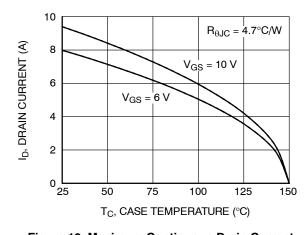


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

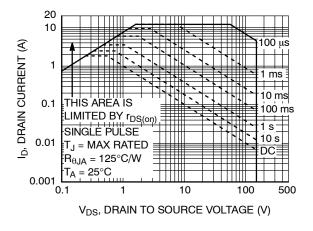


Figure 11. Forward Bias Safe Operating Area

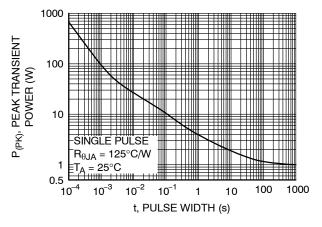


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

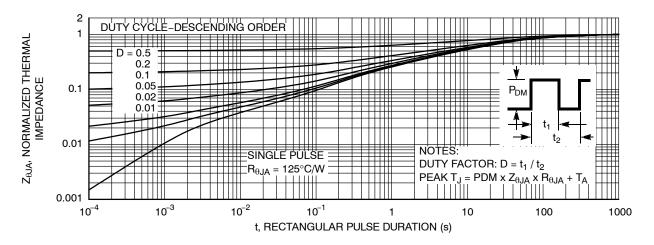


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

ORDERING INFORMATION

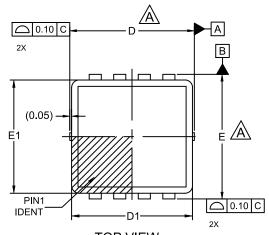
Device	Device Marking	Package Type	Reel Size	Tape Width	Shipping [†]
FDMC86244	FDMC86244	WDFN8 3.3x3.3, 0.65P Power 33 (Pb-Free)	13"	12 mm	3000 / Tape & Reel
FDMC86244-L701	FDMC86244	WDFN8 3.3x3.3, 0.65P Power 33 (Pb-Free)	13"	12 mm	3000 / Tape & Reel

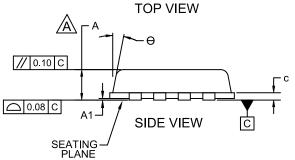
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

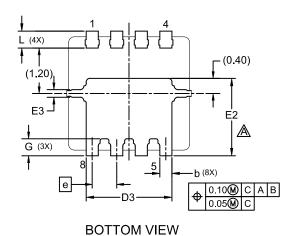
PACKAGE DIMENSIONS

WDFN8 3.3x3.3, 0.65P

CASE 511DR ISSUE A



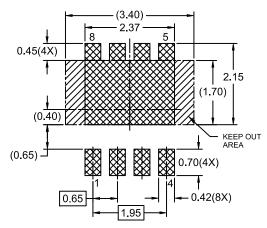




NOTES:

- A. DIMENSIONS ARE IN MILLIMETERS.
- B. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- C. SEATING PLANE IS DEFINED BY TERMINAL TIPS ONLY
- D. BODY DIMENSIONS DO NOT INCLUDE MOLD FLASH PROTRUSIONS NOR GATE BURRS. MOLD FLASH PROTRUSION OR GATE BURR DOES NOT EXCEED 0.150MM.

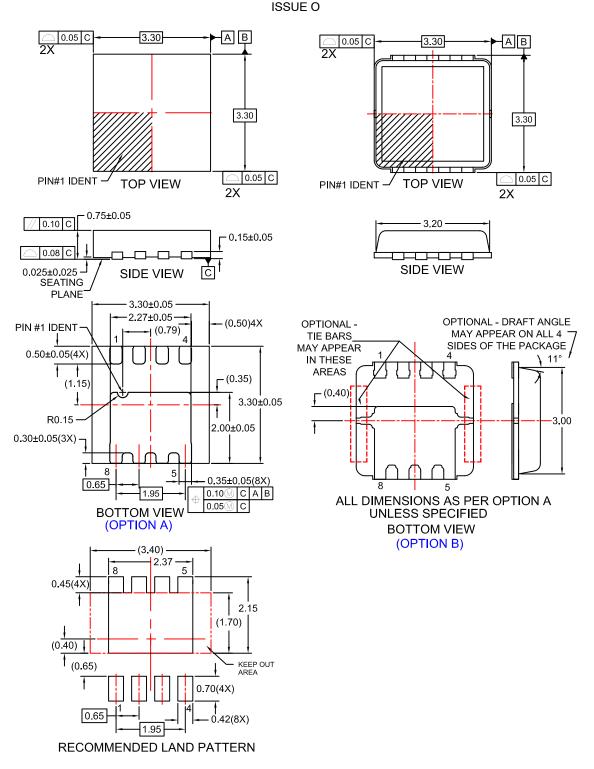
I _{ЫМ}	MILLIMETERS				
DIN	MIN	NOM	MAX		
Α	0.70	0.75	0.80		
A1	0.00	-	0.05		
b	0.27	0.32	0.37		
С	0.15	0.20	0.25		
D	3.20	3.30	3.40		
D1	3.10	3.20	3.30		
D3	2.17	2.27	2.37		
Е	3.20	3.30	3.40		
E1	2.90	3.00	3.10		
E2	1.95	2.05	2.15		
E3	0.15	0.20	0.25		
е	0.65 BSC				
G	0.40	0.45	0.50		
L	0.40	0.45	0.50		
θ	0	-	12		



RECOMMENDED LAND PATTERN

PACKAGE DIMENSIONS

WDFN8 3.3x3.3, 0.65P CASE 511DQ



ON Semiconductor and (III) are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability. arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthhorized use, even if such claim alleges that ON Semiconductor was negligent regarding the design or manufacture of the part. ON Semiconductor is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT: Email Requests to: orderlit@onsemi.com

ON Semiconductor Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800–282–9855 Toll Free USA/Canada

Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET category:

Click to view products by ON Semiconductor manufacturer:

Other Similar products are found below:

614233C 648584F IRFD120 JANTX2N5237 FCA20N60_F109 FDZ595PZ 2SK2545(Q,T) 405094E 423220D TPCC8103,L1Q(CM MIC4420CM-TR VN1206L SBVS138LT1G 614234A 715780A NTNS3166NZT5G SSM6J414TU,LF(T 751625C BUK954R8-60E NTE6400 SQJ402EP-T1-GE3 2SK2614(TE16L1,Q) 2N7002KW-FAI DMN1017UCP3-7 EFC2J004NUZTDG ECH8691-TL-W FCAB21350L1 P85W28HP2F-7071 DMN1053UCP4-7 NTE221 NTE222 NTE2384 NTE2903 NTE2941 NTE2945 NTE2946 NTE2960 NTE2967 NTE2969 NTE2976 NTE455 NTE6400A NTE2910 NTE2916 NTE2956 NTE2911 DMN2080UCB4-7 TK10A80W,S4X(S SSM6P69NU,LF DMP22D4UFO-7B